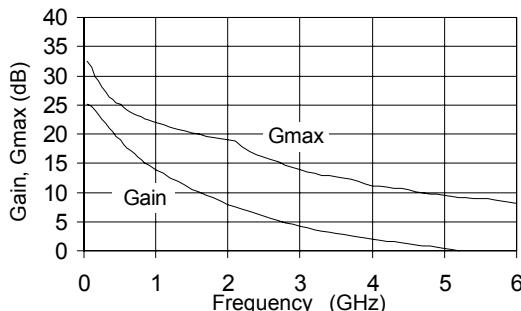


Product Description

Sirenza Microdevices' SHF-0589 is a high performance AlGaAs/GaAs Heterostructure FET (HFET) housed in a low-cost surface-mount plastic package. The HFET technology improves breakdown voltage while minimizing Schottky leakage current resulting in higher PAE and improved linearity.

Output power at 1dB compression is +33.4 dBm when biased for Class AB operation at 7V,345mA at 1.96 GHz. The +46.5 dBm third order intercept makes it ideal for high dynamic range, high intercept point requirements. It is well suited for use in both analog and digital wireless communication infrastructure and subscriber equipment including 3G, cellular, PCS, fixed wireless, and pager systems.

Typical Gain Performance (7V,345mA)



SHF-0589

0.05-3 GHz, 2 Watt GaAs HFET



Product Features

- High Linearity Performance at 1.96 GHz
 - +33.4 dBm P1dB
 - +46.5 dBm OIP3
 - +26 dBm IS-95 Channel Power
 - +11.5 dB Gain
- +23.7 dBm W-CDMA Channel Power
- High Drain Efficiency (>50% at P1dB)

Applications

- Analog and Digital Wireless Systems
- 3G, Cellular, PCS
- Fixed Wireless, Pager Systems

Symbol	Device Characteristics	Test Conditions, 25°C $V_{DS}=7V$, $I_{DQ}=345mA$ (unless otherwise noted)	Test Frequency	Units	Min	Typ	Max
Gmax	Maximum Available Gain	$Z_s=Z_s^*$, $Z_l=Z_l^*$	0.90 GHz 1.96 GHz 2.14 GHz	dB dB dB	- 17.4 16.6	22.9 11.5 12.7	-
S_{21}	Insertion Gain [1]	$Z_s=Z_l = 50$ Ohms	0.90 GHz	dB	14.1	15.7	17.3
Gain	Power Gain [2]	Application Circuit	1.96 GHz	dBm	10.3	11.5	-
OIP3	Output Third Order Intercept Point [2]	Application Circuit	1.96 GHz	dBm	44	46.5	-
P1dB	Output 1dB Compression Point [2]	Application Circuit	1.96 GHz	dBm	31.9	33.4	-
P_{CHAN}	IS-95 Channel Power (-45dBc ACPR)	Application Circuit	1.96 GHz	dBm	-	26.2	-
NF	Noise Figure [2]	Application Circuit	1.96 GHz	dB	-	3.7	-
I_{DSS}	Saturated Drain Current	$V_{DS}=V_{DSP}$, $V_{GS}=0V$		mA	816	1176	1536
g_m	Transconductance	$V_{DS}=V_{DSP}$, $V_{GS}=-0.25V$		mS	576	792	1008
V_p	Pinch-Off Voltage [1]	$V_{DS}=2.0V$, $I_{DS}=2.4mA$		V	-3.0	-1.9	-1.0
BV_{GS}	Gate-Source Breakdown Voltage [1]	$I_{GS}=4.8mA$, drain open		V	-	-17	-15
BV_{GD}	Gate-Drain Breakdown Voltage [1]	$I_{GD}=4.8mA$, $V_{GS}=-5.0V$		V	-	-22	-17
Rth	Thermal Resistance	junction-to-lead		°C/W	-	23	-
V_{DS}	Operating Voltage [3]	drain-source		V	-	-	8.0
I_{DQ}	Operating Current [3]	drain-source, quiescent		mA	-	-	480
P_{DSS}	Power Dissipation [3]			C	-	-	2.4

[1] 100% tested - Insertion gain tested using a 50 ohm contact board (no matching circuitry) during final production test.

[2] Sample tested - Samples pulled from each wafer/package lot. Sample test specifications are based on statistical data from sample test measurements. The test fixture is an engineering application circuit board. The application circuit was designed for the optimum combination of linearity, P1dB, and VSWR.

[3] Maximum recommended power dissipation is specified to maintain $T \leq 140C$ at $T_f=85C$. $V_{DS} * I_{DQ} < 2.4W$ is recommended for continuous reliable operation.

The information provided herein is believed to be reliable at press time. Sirenza Microdevices assumes no responsibility for inaccuracies or omissions. Sirenza Microdevices assumes no responsibility for the use of this information, and all such information shall be entirely at the user's own risk. Prices and specifications are subject to change without notice. No patent rights or licenses to any of the circuits described herein are implied or granted to any third party. Sirenza Microdevices does not authorize or grant any Sirenza Microdevices product for use in life support devices and/or systems.

Copyright 2000 Sirenza Microdevices, Inc. All worldwide rights reserved.

522 Almanor Ave., Sunnyvale, CA 94085

Phone: (800) SMI-MMIC

<http://www.sirenza.com>

Absolute Maximum Ratings

MTTF is inversely proportional to the device junction temperature. For junction temperature and MTTF considerations the bias condition should also satisfy the following expression:

$$P_{DC} < (T_J - T_L) / R_{TH}$$

where:

$$P_{DC} = I_{DS} * V_{DS} (W)$$

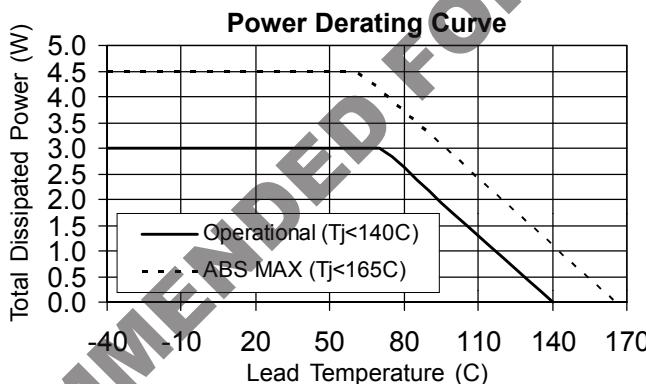
T_J = Junction Temperature ($^{\circ}$ C)

T_L = Lead Temperature (pin 4) ($^{\circ}$ C)

R_{TH} = Thermal Resistance ($^{\circ}$ C/W)

Parameter	Symbol	Value	Unit
Drain Current	I_{DS}	640	mA
Forward Gate Current	I_{GSF}	4.8	mA
Reverse Gate Current	I_{GSR}	4.8	mA
Drain-to-Source Voltage	V_{DS}	9.0	V
Gate-to-Source Voltage	V_{GS}	<5 or >0	V
RF Input Power	P_{IN}	800	mW
Operating Lead Temperature	T_L	See Graph	$^{\circ}$ C
Storage Temperature Range	T_{stor}	-40 to +165	$^{\circ}$ C
Power Dissipation	P_{DISS}	See Graph	W
Channel Temperature	T_J	165	$^{\circ}$ C

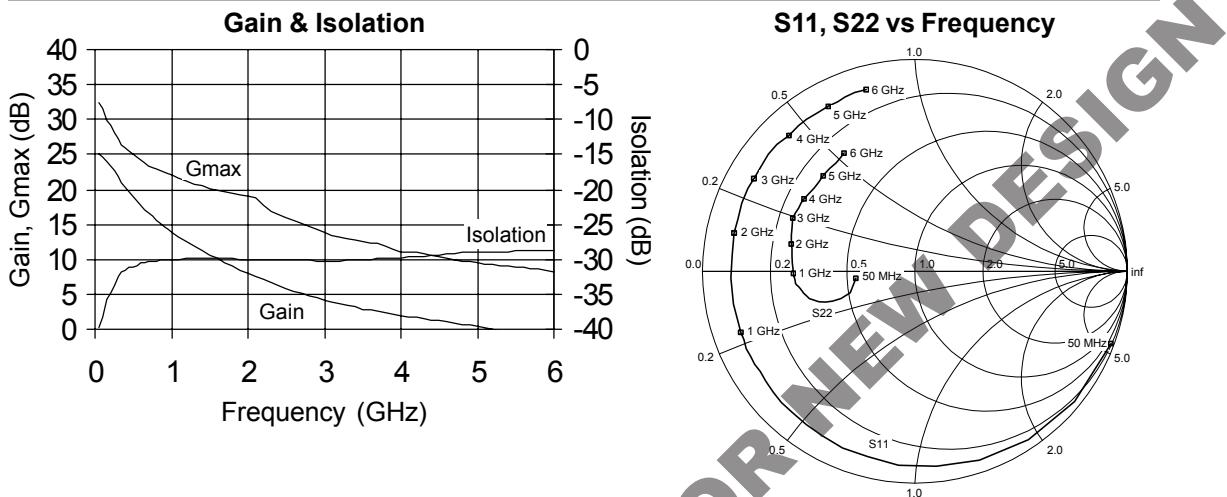
Operation of this device beyond any one of these limits may cause permanent damage. For reliable continuous operation, the device voltage and current must not exceed the maximum operating values specified in the table on page 1.



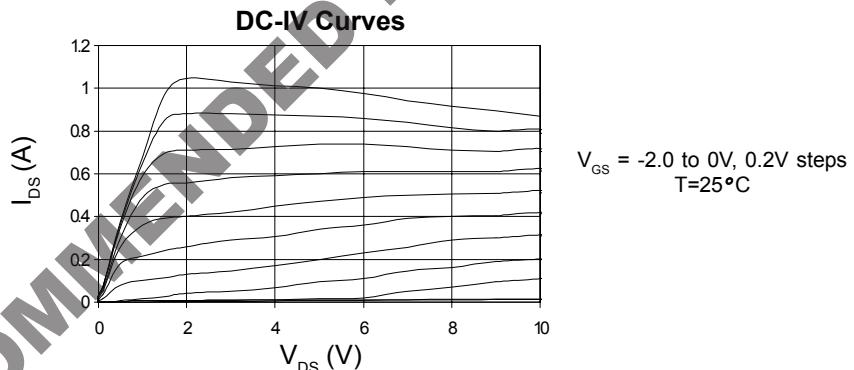
Design Considerations and Trade-offs

1. The SHF-0x89 is a depletion mode FET and requires a negative gate voltage. Normal pinchoff variation from part-to-part precludes the use of a fixed gate voltage for all devices. Active bias circuitry or manual gate bias alignment is recommended to maintain acceptable performance (RF and thermal).
2. Active bias circuitry is strongly recommended for class A operation (backoff >6dB).
3. For large signal operation (<6dB backoff) class AB operation is required to maximize the FET's performance. Passive gate bias circuitry is generally required to achieve pure class AB performance. This is generally accomplished using a voltage divider with temperature compensation. Per item 1 above the gate voltage should be aligned for each device to eliminate the effects of pinchoff process variation.
4. Choose the operating voltage based on the amount of backoff. For large signal operation the drain-source voltage should be increased to 8V to maximize P1dB. For small signal operation OIP3 may be improved by reducing the voltage and increasing the current. The recommended application circuit should be re-optimized if the recommended 7V bias condition is not used. Make sure the quiescent bias condition does not exceed the recommended power dissipation limit (shown on page 1).

De-embedded S-Parameters ($Z_s=Z_L=50$ Ohms, $V_{DS}=7V$, $I_{DS}=345mA$, $25^\circ C$)



Note: S-parameters are de-embedded to the device leads with $Z_s=Z_L=50\Omega$. The data represents typical performance of the device. De-embedded s-parameters can be downloaded from our website (www.sirenza.com).



Typical Performance - Engineering Application Circuits

Freq (MHz)	V_{DS} (V)	I_{DS} (mA)	P1dB (dBm)	-45dBc Channel Power (dBm)	-55dBc Channel Power (dBm)	OIP3 ^[6] (dBm)	Gain (dB)	S11 (dB)	S22 (dB)	NF (dB)
900	7	345	32.0	25.7 ^[4]	23.2 ^[4]	45.0	16.3	-20	-10	3.6
1960	7	345	33.4	26.2 ^[4]	23.2 ^[4]	46.5	11.5	-15	-12	3.7
2140	7	345	32.7	23.7 ^[5]	20.5 ^[5]	46.4	11.1	-15	-12	4.4

[4] IS-95 CDMA Channel Power (9 Fwd Channels, 885kHz offset, 30kHz Adj Chan BW)

[5] W-CDMA Channel Power (64 DPCCH, 5MHz offset, 3.84MHz Adj Chan BW)

[6] $P_{OUT} = +15$ dBm per tone, 1MHz tone spacing


Caution: ESD sensitive

Appropriate precautions in handling, packaging and testing devices must be observed.

Pin Description

Pin #	Function	Description
1	Gate	RF Input
2	Source	Connection to ground. Use via holes to reduce lead inductance. Place vias as close to ground leads as possible.
3	Drain	RF Output
4	Source	Same as Pin 2

Mounting and Thermal Considerations

It is very important that adequate heat sinking be provided to minimize the device junction temperature. The following items should be implemented to maximize MTTF and RF performance.

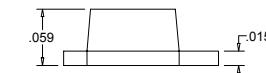
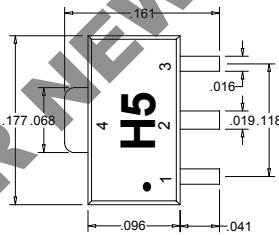
1. Multiple solder-filled vias are required directly below the ground tab (pin 4). [CRITICAL]
2. Incorporate a large ground pad area with multiple plated-through vias around pin 4 of the device. [CRITICAL]
3. Use two point board seating to lower the thermal resistance between the PCB and mounting plate. Place machine screws as close to the ground tab (pin 4) as possible. [CRITICAL]
4. Use 2 ounce copper to improve the PCB's heat spreading capability. [CRITICAL]
5. Thermal transfer paste should be used between the PCB and the mounting plate to improve heat spreading capability. [RECOMMENDED]

SHF-0589 2 Watt HFET
Part Number Ordering Information

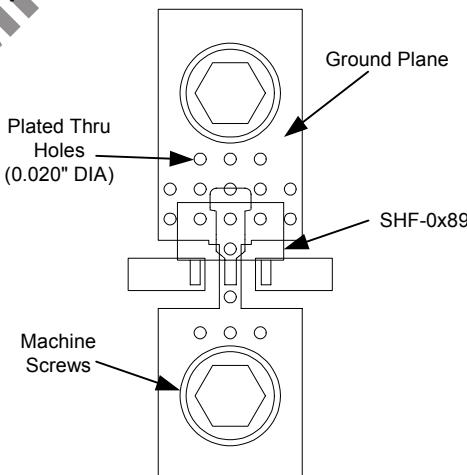
Part Number	Reel Size	Devices/Reel
SHF-0589	7"	1000

Part Symbolization

The part will be symbolized with the "H5" designator and a dot signifying pin 1 on the top surface of the package.

Package Dimensions


DIMENSIONS ARE IN INCHES

Recommended Mounting Configuration for Optimum RF and Thermal Performance


SUNSTAR 商斯达实业集团是集研发、生产、工程、销售、代理经销、技术咨询、信息服务等为一体的高科技企业，是专业高科技电子产品生产厂家，是具有 10 多年历史的专业电子元器件供应商，是中国最早和最大的仓储式连锁规模经营大型综合电子零部件代理分销商之一，是一家专业代理和分销世界各大品牌 IC 芯片和电子元器件的连锁经营综合性国际公司，专业经营进口、国产名厂名牌电子元件，型号、种类齐全。在香港、北京、深圳、上海、西安、成都等全国主要电子市场设有直属分公司和产品展示展销窗口门市部专卖店及代理分销商，已在全国范围内建成强大统一的供货和代理分销网络。我们专业代理经销、开发生产电子元器件、集成电路、传感器、微波光电元器件、工控机/DOC/DOM 电子盘、专用电路、单片机开发、MCU/DSP/ARM/FPGA 软件硬件、二极管、三极管、模块等，是您可靠的一站式现货配套供应商、方案提供商、部件功能模块开发配套商。商斯达实业公司拥有庞大的资料库，有数位毕业于著名高校——有中国电子工业摇篮之称的西安电子科技大学（西军电）并长期从事国防尖端科技研究的高级工程师为您精挑细选、量身订做各种高科技电子元器件，并解决各种技术问题。

微波光电部专业代理经销高频、微波、光纤、光电元器件、组件、部件、模块、整机；电磁兼容元器件、材料、设备；微波 CAD、EDA 软件、开发测试仿真工具；微波、光纤仪器仪表。欢迎国外高科技微波、光纤厂商将优秀产品介绍到中国、共同开拓市场。长期大量现货专业批发高频、微波、卫星、光纤、电视、CATV 器件：晶振、VCO、连接器、PIN 开关、变容二极管、开关二极管、低噪晶体管、功率电阻及电容、放大器、功率管、MMIC、混频器、耦合器、功分器、振荡器、合成器、衰减器、滤波器、隔离器、环行器、移相器、调制解调器；光电子元器件和组件：红外发射管、红外接收管、光电开关、光敏管、发光二极管和发光二极管组件、半导体激光二极管和激光器组件、光电探测器和光接收组件、光发射接收模块、光纤激光器和光放大器、光调制器、光开关、DWDM 用光发射和接收器件、用户接入系统光光收发器件与模块、光纤连接器、光纤跳线/尾纤、光衰减器、光纤适配器、光隔离器、光耦合器、光环行器、光复用器/转换器；无线收发芯片和模组、蓝牙芯片和模组。

更多产品请看本公司产品专用销售网站：

商斯达中国传感器科技信息网：<http://www.sensor-ic.com/>

商斯达工控安防网：<http://www.pc-ps.net/>

商斯达电子元器件网：<http://www.sunstare.com/>

商斯达微波光电产品网：<HTTP://www.rfoe.net/>

商斯达消费电子产品网：<http://www.icasic.com/>

商斯达实业科技产品网：<http://www.sunstars.cn/> 微波元器件销售热线：

地址：深圳市福田区福华路福庆街鸿图大厦 1602 室

电话：0755-82884100 83397033 83396822 83398585

传真：0755-83376182 (0) 13823648918 MSN：SUNS8888@hotmail.com

邮编：518033 E-mail：szss20@163.com QQ：195847376

深圳赛格展销部：深圳华强北路赛格电子市场 2583 号 电话：0755-83665529 25059422

技术支持：0755-83394033 13501568376

欢迎索取免费详细资料、设计指南和光盘；产品凡多，未能尽录，欢迎来电查询。

北京分公司：北京海淀区知春路 132 号中发电子大厦 3097 号

TEL：010-81159046 82615020 13501189838 FAX：010-62543996

上海分公司：上海市北京东路 668 号上海赛格电子市场 D125 号

TEL：021-28311762 56703037 13701955389 FAX：021-56703037

西安分公司：西安高新区 20 所(中国电子科技集团导航技术研究所)

西安劳动南路 88 号电子商城二楼 D23 号

TEL：029-81022619 13072977981 FAX:029-88789382